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Sheet 1 of 1

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

107156-00216

SERIAL NO.

10/730,031

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT

T. Oishi et al.

FILING DATE

December 9, 2003

GROUP

2821

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
<i>ML</i>	AA	5,521,759	5/28/96	Dobrowolski et al.			
<i>ML</i>	AB	6,469,685	10/22/02	Woodruff et al.			

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION		
							YES	NO	PART.
<i>ML</i>	AC	2000-156182	6/6/00	Japan				X	
	AD	EP 1 199 738 A2	4/24/02	Europe					
	AE	EP 0 782 164 A1	7/2/97	Europe					
	AF	WO 98/59335	12/30/98	WIPO					
	AG	EP 0 908 920 A2	4/14/99	Europe					
	AH	EP 0 930 637 A2	12/16/98	Europe					
	AI	EP 0 977 060 A2	2/2/00	Europe					
	AJ	EP 1 056 325 A2	11/29/00	Europe					
	AK	EP 1 056 324 A2	11/29/00	Europe					
	AL	EP 1 069 088 A1	1/17/01	Europe					
	AM	EP 1 176 436 A1	1/30/02	Europe					
	AN	EP 1 253 816 A2	10/30/02	Europe					
	AO	EP 1 280 179 A2	1/29/03	Europe					
	AP	EP 1 339 082 A1	8/27/03	Europe					
	AQ	EP 1 275 985 A2	1/15/03	Europe					
<i>✓</i>	AR	EP 1 275 986 A2	1/15/03	Europe					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AS	
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EXAMINER

*ML*

DATE CONSIDERED

*12/10/05*

\*EXAMINER:

Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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New application

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Not Assigned

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	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

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		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION		
							YES	NO	PART.
<i>MM</i>	AG	11-219122	8/10/99	Japan					X
	AH								
	AI								
	AJ								
	AK								
	AL								

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AM	
	AN	
	AO	

EXAMINER

*W. H. Sch*

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